Concepts and Mechanisms of Dependable Systems

Summer Term 2008

References and Readings:

Paulo Veríssimo, Luís Rodrigues: **Distributed Systems for System Architects**Kluwer Academic Publishers, Boston, January 2001

Eugen Schäfer: "Zuverlässigkeit, Verfügbarkeit und Sicherheit in der Elektronik, Eine Brücke von der Zuverlässigkeittheorie zu den Aufgaben der Zuverlässigkeitspraxis", 1. Auflage, Vogel Verlag, 1979, ISBN 3-0823-0586-8,

Karl-Erwin Großpietsch: "Zuverlässigkeitstheoretische Grundlagen", GMD-Seminar, St. Augustin

Stefan Poledna: "Lecture on Fault-Tolerant Systems", Vorlesungsfolien, Institut für Technische Informatik, TU Wien, SoSe 1996

Dependability

Dependability:

The dependability of a system is its ability to deliver specified services to the end users so that they can justifiably rely on and trust the services provided by the system.

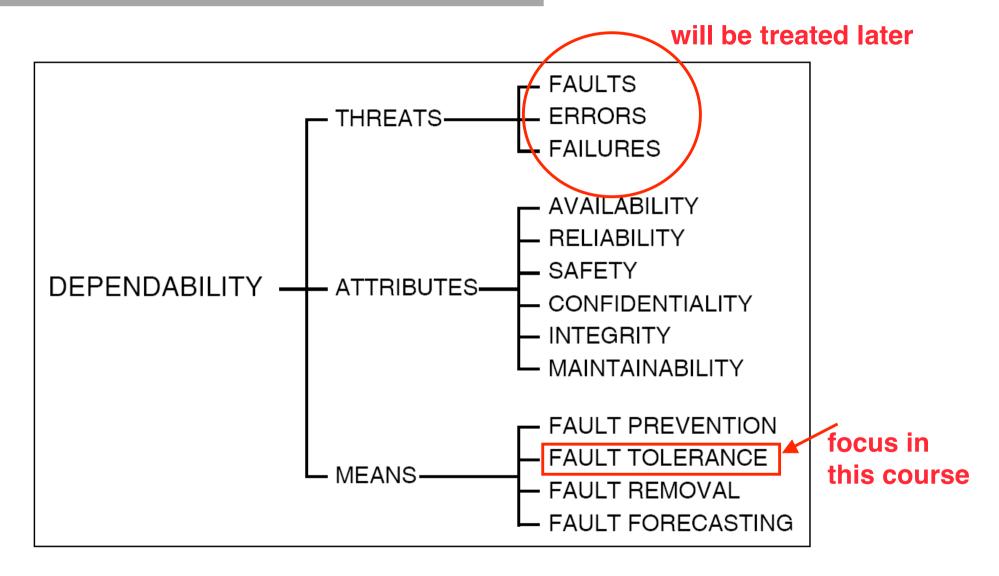
The function or service is the behaviour which can be observed at the interface to other systems which interact with the observed system. Quality referes to the conformance to the specifications.

Algirdas Avižienis, Jean-Claude Laprie, Brian Randell

Fundamental Concepts of Dependability

UCLA CSD Report no. 010028 LAAS Report no. 01-145 Newcastle University Report no. CS-TR-739

Dependability Tree



Attributes of Dependability

Dependability has several attributes, including reliability, availability, maintainability, security (with aspects like privacy, confidentiality and integrity) and safety.

Availability: The availability of a system for a period (0,t) is the probability that the

system is available for use at any random time in (0,t).

Reliability: The reliability of a system for a period (0,t) is the probability that the system

is continuously operational (i.e., does not fail) in time interval (0,t) given that

it is operational at time 0.

Maintainability: The maintainability of a system is a measure of the ability of the system to

undergo maintenance or to return to normal operation after a failure.

Confidentiality: The confidentiality of a system is a measure of the degree to which the

system can ensure that an unauthorized user will not be able to understand

protected information in the system.

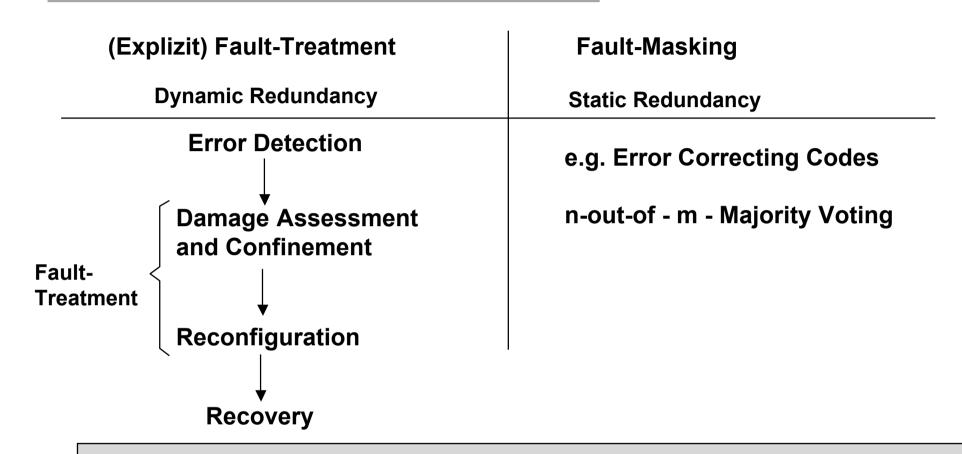
Integrity The integrity of a system is the probability that errors or attacks will not lead

to damages to the state of the system, including data, code, etc.

Safety: The safety of a system for a period (0,t) is the probability that the system

will not incur any catastrophic failures in time interval (0,t).

Mechanisms of Fault-Tolerance





- Information Redundancy
- Component Redundancy
- Time Redundancy



How to determine reliability of composed systems?

Structure-based modelling:

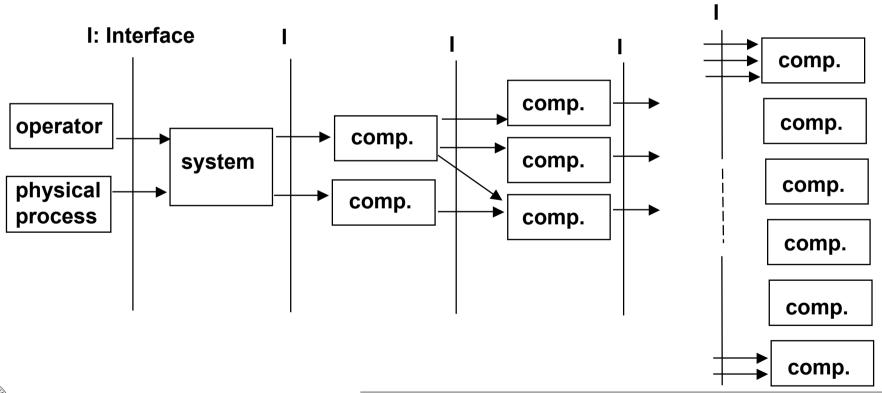
- identifiable independent components
- every component has an individual reliability
- the construction of the model is based on the connection structure

How to determine reliability of composed systems?

A System is defined by:

- its structure, i.e.the topology of its components
- its behaviour, i.e. by the overall behaviour of all of its components

system components are organized in a hierarchical way. This results in a dependency relation (\rightarrow) between the system layers.



Determining reliability quantitatively by reliability diagrams

Probability of a correctly working component:

For every part of the system we distinguish two states:

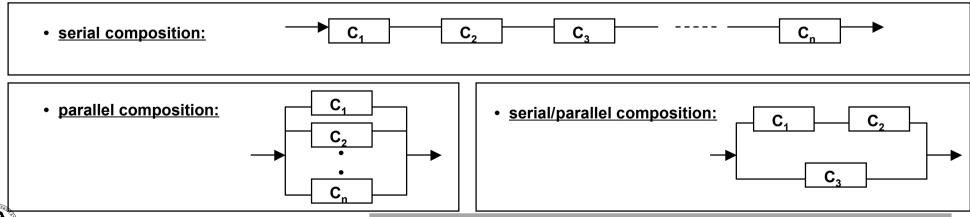
- intact (correctly working component)
- failed

<u>C-Probability (probability of working correctly)</u> of a component is defined by: Probability that the component exhibits the specified behaviour.

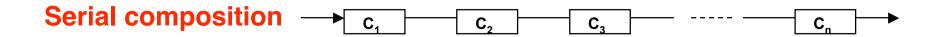
A system is fault-tolerant, if it is showing the overall specified behaviour while some components fail.

Reliability Diagrams (do not mix up with electrical schematics):

Abstracting a system in components. Every component has a specified reliability.



Probability for a correctly working system:



 $P_{\text{series}} = P(C_1 \text{ intact}) \text{ and } P(C_2 \text{ intact}) \text{ and } \dots P(C_n \text{ intact})$

Assumption: The properties (C_i intact) (i=1,..,n) are independent.

$$P_{\text{series}} = P(C_1 \text{ intact}) \cdot P(C_2 \text{ intact}) \cdot \dots \cdot P(C_n \text{ intact})$$

with p_i: probability of unfailed component (C-probability):

$$P_{\text{series}} = p_1 \cdot p_2 \cdot \dots \cdot p_n$$

Examplel:

n identical Components:

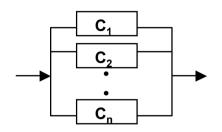
$$P_{\text{series}}$$
 for p_i^n , $n = 5$, $p_i = 0.99$: $P_{\text{series}} = 0.99^5 = 0.95$
 P_{series} for p_i^n , $n = 5$, $p_i = 0.70$: $P_{\text{series}} = 0.70^5 = 0.16$

Probability for a correctly working system:

parallel composition

Probability of failure (F-probability) = 1 - C-probability (correct and failed are complementary events).

$$P_{parallel} = P(C_1 \text{ failed}) \text{ and } P(C_2 \text{ failed}) \text{ and } \dots P(C_n \text{ failed})$$



Assumption: The properties (C_i failed) (i=1,..,n) are independent..

$$P_{\text{parallel}} = P(C_1 \text{ failed}) \cdot P(C_2 \text{ failed}) \cdot \dots \cdot P(C_n \text{ failed})$$

p_i: F-probability of component i:

$$\mathbf{P}_{\text{parallel}} = \mathbf{1} - (\mathbf{p}_1 \cdot \mathbf{p}_2 \cdot \dots \cdot \mathbf{p}_n)$$

Example F-probability:

n identical Components:



k-out-of-n - Systeme

Systems of n components in which at least k components are working correctly.

Probability that exactly k defined components are correct (components 1,..,k), while the other n-k components failed (componenten k+1,...,n) is given by:

$$P_{k-aus-n} = p_1 \cdot p_2 \cdot \cdot p_k \cdot (1 - p_{k+1}) \cdot (1 - p_{i+2}) \cdot \cdot (1 - p_n)$$

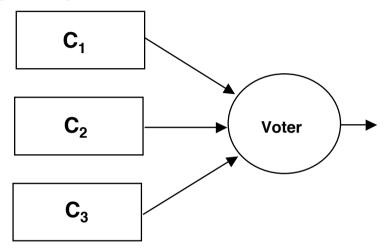
There are $\binom{n}{i}$ possibilities, to select i components out of n components:

$$P_{k-out-of-n} = \sum_{i=k}^{n} \binom{n}{i} p^{i} \cdot (1-p)^{n-i}$$

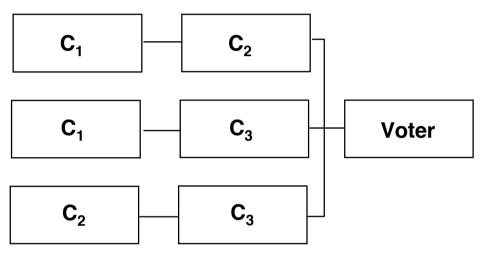
Example: 2-out-of-3 System:
$$\binom{3}{2}$$
 $p^2 \cdot (1-p)^{3-2} + \binom{3}{3}$ $p^3 \cdot (1-p)^{3-3} = 3 \cdot p^2 \cdot (1-p) + p^3 \cdot 1$

Example TMR (Triple Modular Redundancy: 2-out-of-3 system)

(electr.) block schematics



reliability diagram



$$P_{TMR} = (p^3 + 3 p^2 \cdot (1 - p)) \cdot p_{voter}$$

$$p = 0.9, p_{voter} = 0.99: P_{TMR} = (0.9^{3} + 3 \cdot 0.9^{2} \cdot (1 - 0.9)) \cdot 0.99$$

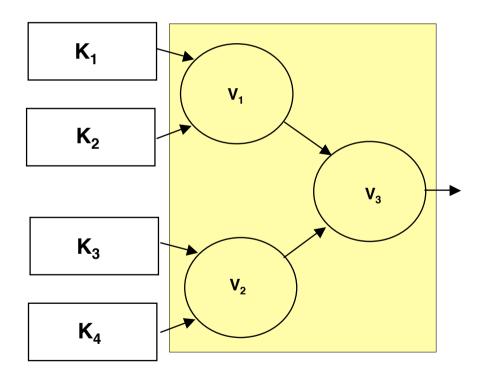
$$= (0.729 + 3 \cdot 0.81 \cdot (1 - 0.9)) \cdot 0.99$$

$$= (0.729 + 2.43 \cdot 0.1) \cdot 0.99 = 0.972 \cdot 0.99$$

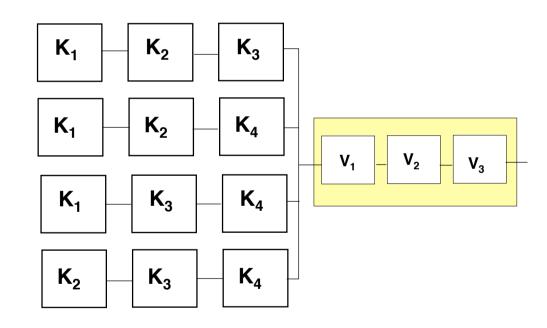
$$= 0.96228$$

Example Pair&Spare (3-out-of-4-System)

(electr.) block schematics



reliability diagram



Example Pair&Spare (3-out-of-4-System)

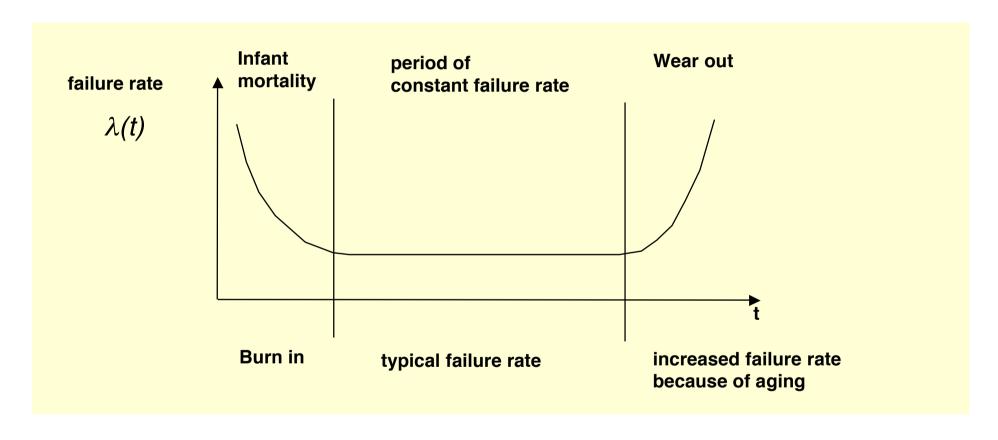
$$\begin{split} P_{P\&S} &= (p^4 + 4 \ p^3 \cdot (1 - p) \) \cdot p_{voter} \\ p &= 0.9, \ p_{voter} = 0.99 \colon P_{P\&S} = (0.9^4 + 4 \cdot 0.9^3 \cdot (1 \cdot 0.9)) \cdot 0.99 \\ &= (0.656 + 4 \cdot 0.73 \cdot (1 \cdot 0.9)) \cdot 0.99 \\ &= (0.656 + 2.92 \cdot 0.1) \cdot 0.99 = 0.948 \cdot 0.99 \\ &= 0.9385 \\ p &= 0.9, \ p_{v1,2} = 0.99, \ p_{v3} = 0.999 \colon \\ P_{P\&S} &= (0.9^4 + 4 \cdot 0.9^3 \cdot (1 \cdot 0.9)) \cdot 0.99^2 \cdot 0.999 \\ &= (0.656 + 4 \cdot 0.73 \cdot (1 \cdot 0.9)) \cdot 0.979 \\ &= (0.656 + 2.92 \cdot 0.1) \cdot 0.99 = 0.948 \cdot 0.9879 \\ &= 0.928 \end{split}$$



How to derive the probability of component failure?

Where to start? Counting the number of failing components over time.

The "bath tub" curve



Typical failure rates:

VLSI-Chip: 10⁻⁸ failures/h = 1 failure during 115000 years

Note:

The failure rate is defined relative to the number of correct components. In a certain time interval, if always the same number of components fail, the failure rate increases relatitively to the number of correct components that becomes smaller by every failed component.

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Lifetime T

Time interval from the mission start to a non-repairable failure

Failure Rate λ (t)

number of failures per time unit

Probability of failure F(t)

probability to fail in the interval [0,T], $T < t_i$.

Reliability R(t)

Probability that a component did not fail until time t_i . F(t) is the complement to R(t).

$$R(t) = 1 - F(t)$$

for non repairable systems R(t) is a monotonely decreasing function. $R(0) \le 1$, $R(\infty) = 0$

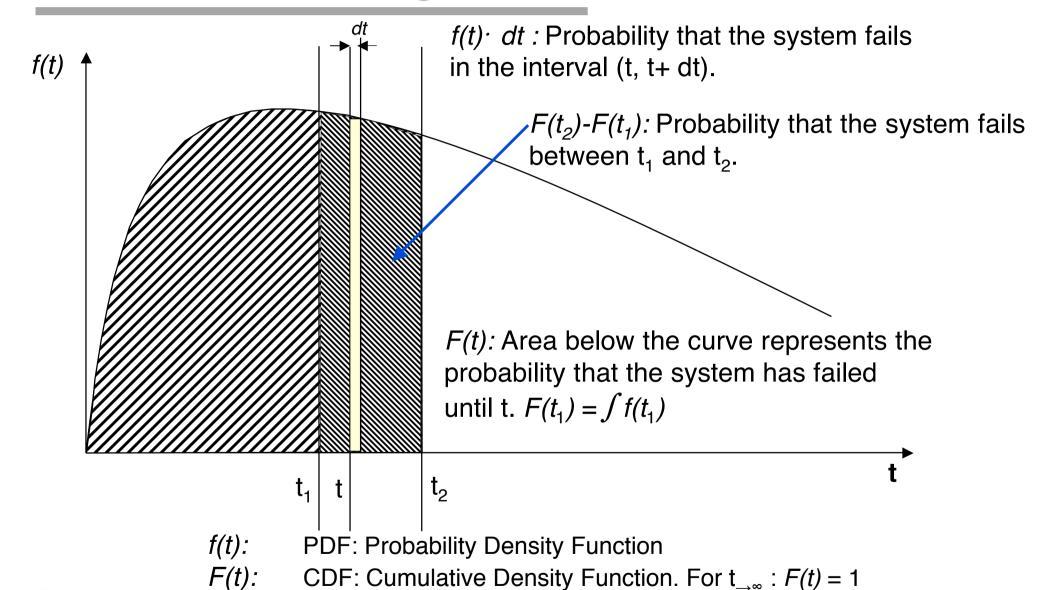
Probability density function f(t)

- f(t) models how failures probabilities are distributed over time
- f(t) dt is the probability that a failure occurs in interval (t, t+dt))

$$f(t) = \frac{dF(t)}{dt} = -\frac{dR(t)}{dt}$$



Life time modelling

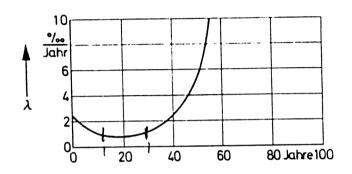




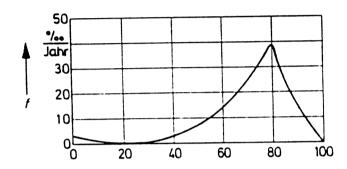
Probability distribution for human life

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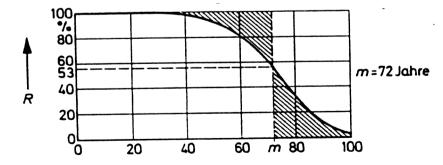
failure rate λ (t)



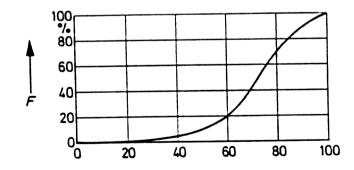
probability density f(t)



Reliability R(t)

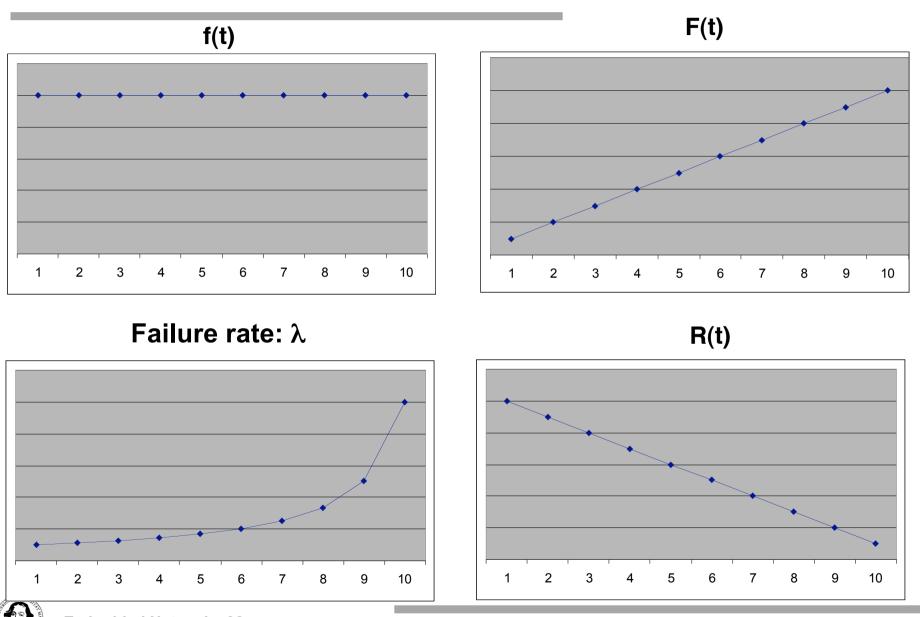


failure probablity F(t)





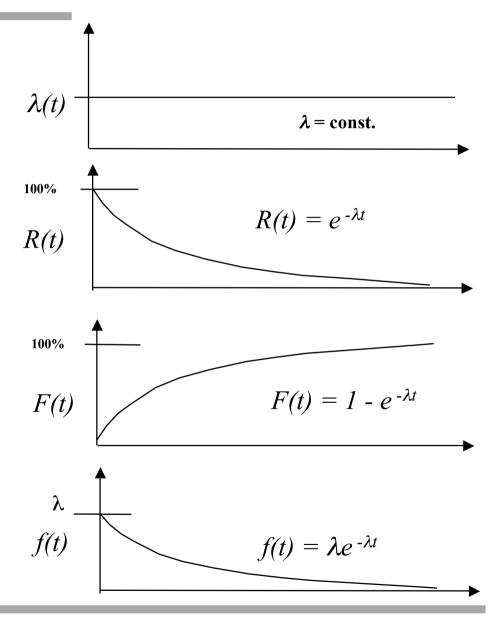
Behaviour under constant probability density



failure rate λ (t) number of failures per hour

Remember: The failure rate is defined relative to the number of correct components. In a certain time interval, if always the same number of components fail, the failure rate increases relatitively to the number of correct components that becomes smaller by every failed component.

If the failure rate remains constant wrt. the set of correct components, this results in an exponential distribution for the reliability R(t).





Summary of Measures

Parameter	Symbol	Unit
life time	T	h
failure probability	F	%
reliability	R	%
probability density	f	%/h
failure rate	λ	1/ h

Assuming
$$\lambda$$
 (t) = const. we have:

$$\frac{1}{\lambda}$$
 = MTBF = MTTFF = MTTF

MTBF: Mean Time Between Failures

MTTFF: Mean Time To First Failure

MTTF: Mean Time To Failure

Availability

time in which the system works correct related to the (down-) time when it is repaired.

$$A = \frac{MTBF}{MTBF + MTTR}$$

Availability Classes

1 year = 525600 minutes = 8760 h

class:	log ₁₀	(1/(1-A))	
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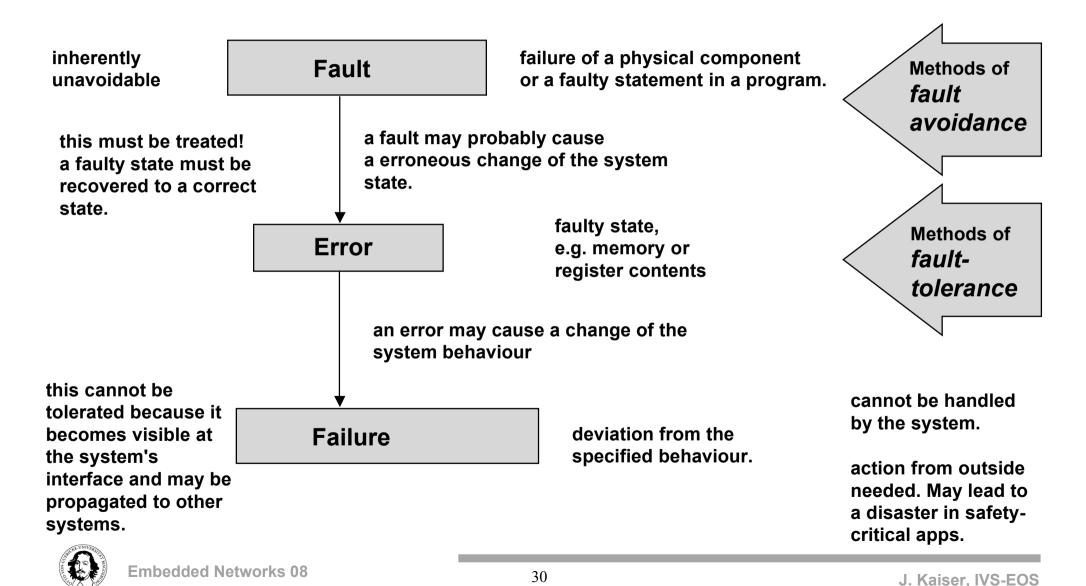
system type	non-availability minutes/year	availability %	class
non-adminitrated systems	50 000	~ 90	1
administrated systems	5 000	99	2
well admin. syst.	500	99,9	3
fault-tolerant syst.	50	99,99	4
high availability syst.	5	99,999	5
very high avail. syst.	0,5	99,9999	6
ultra-high avail. syst.	0,05	99,99999	7

Impairments:

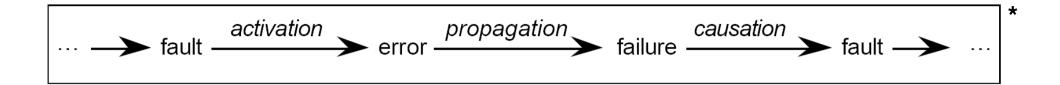
Faults, errors, failures

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The Cause-Effect-Chain: Classifying Impairments



The Cause-Effect-Chain: Classifying Impairments



transitions:

fault → error: A fault which has not been activated by a computation is called

dormant. A fault is activated if it causes an error.

error→ failure: An error is *latent* if it has not yet lead to a failure or has been

detected by some error detection mechanism.

An error is effective if it caused a failure.

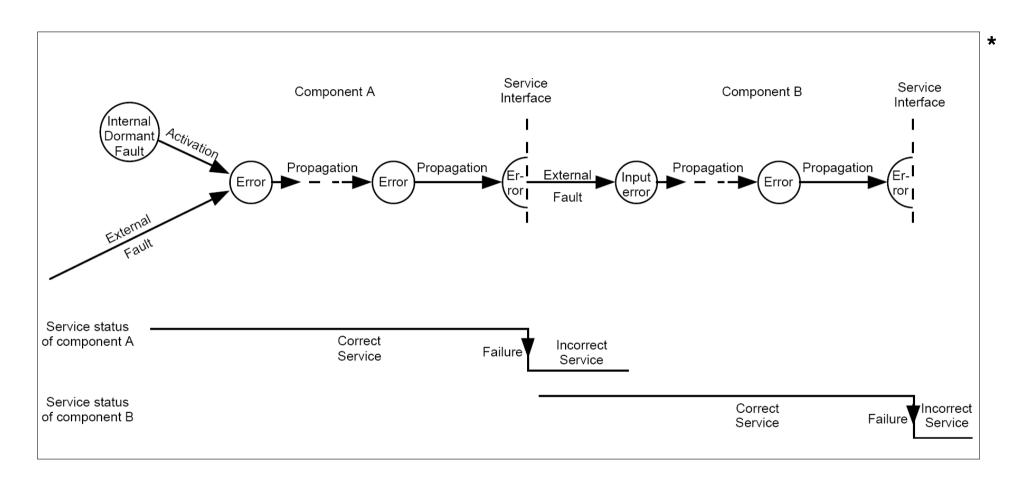
failure→ fault: A fault is caused if the error becomes effective and the specified

service is affected. This failure can be propagated and appears as

a fault on a higher system layer or in a connected component.



The Cause-Effect-Chain: Classifying Impairments



Error Propagation

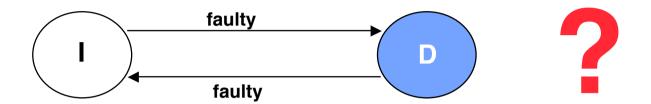
* Algirdas Avižienis, Jean-Claude Laprie, Brian Randell: Fundamental Concepts of Dependability



Concepts and Mechanisms of Dependable Systems

Fault detection in Distributed Systems

System diagnosis to detect and localize faults



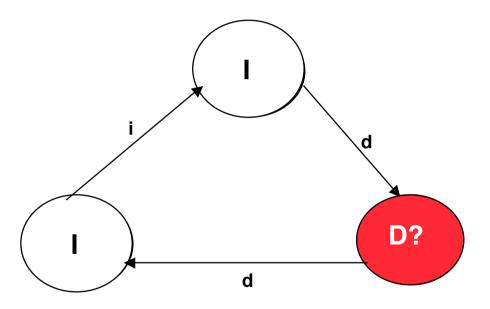
Assumptions:

- components are either faulty or correct.
- a test is complete and correct.
- a correct process wil deliver a correct result.
- a faulty process will deliver an arbitrary result.
- a central correct observer evaluates the result of the test.

F. P. Preparata, G. Metze, and R. T. Chien. On the connection assignment problem of diagnosable systems. IEEE Trans. Electron. Comput., EC--16:848--854, 1967

f – diagnosability

1-diagnosable system



Assumptions:

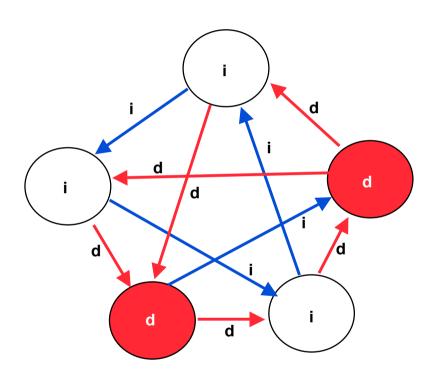
- components are either faulty or correct.
- a test is complete and correct.
- a correct process wil deliver a correct result.
- a faulty process will deliver an arbitrary result.
- a node is marked as faulty if it has an incoming edge originating from a correct node, which has tested this node as faulty
- a central correct observer evaluates the result of the test.

f – diagnosable:

A system with n components is f-diagnosable if $n \ge 2f + 1$ and every component test at least f other components. The components do not test each other.



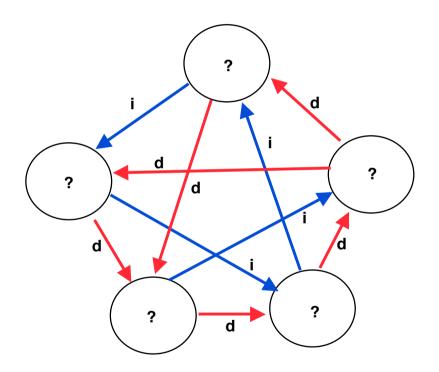
2-diagnosable system



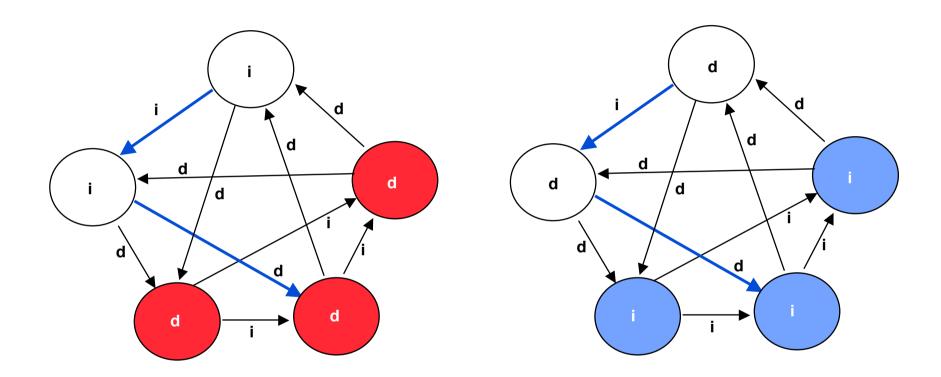
Assumptions:

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- a correct process wil deliver a correct result.
- a faulty process will deliver an arbitrary result.
- a node is marked as faulty if it has an incoming edge originating from a correct node, which has tested this node as faulty
- a central correct observer evaluates the result of the test.

Can diagnosis deliver an unambiguous result?



3 faulty nodes



failure cannot be detected (obviously) because the fault assumption (max. 2 faults) is violated.

Assumption:

Node is the unit of fault-containment and replacement!

Problems:

- 1. What kind of faults have to be considered?
 - Fault model.
- 2. Can we replace the central evaluation component?
 - Distrbuted consensus.
- 3. Can fault-detection always successfully be performed?

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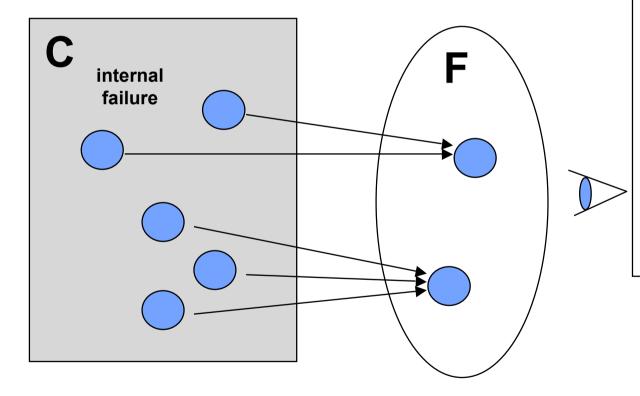
The problem of synchrony.

Abstracting Failures: Failure Semantics

The fault semantics describes the assumptions about the effect of internal failures on the observable behaviour of a system component. It thus describes an abstraction of internal failures.

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C: System component fault class



Problem:

The mechanisms to handle component failures are related to the assumed fault class.

It has to be guaranteed that the fault class F is enforced by the system, i.e. no failure inside the component may lead to a fault not covered by the failure semantics visible at the interface.

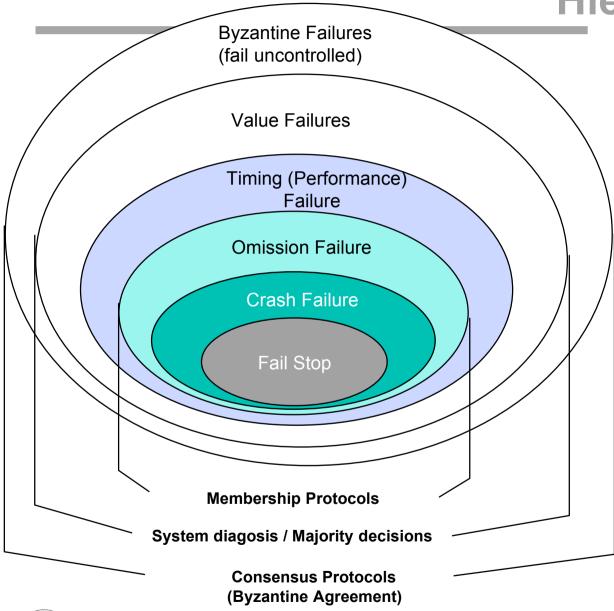
Examples:

Omission-Failure Semantics
Crash-Failure Semantics

S has the failure semantics of F



Hierarchy of Failures



Byzantine Failure: Arbitrary, uncontrolled.

Timing (Prerformance) Failures
Correct values but too early or too late.

Omission Failures:

Special class of timing failures. Correct values are available in time or not at all.

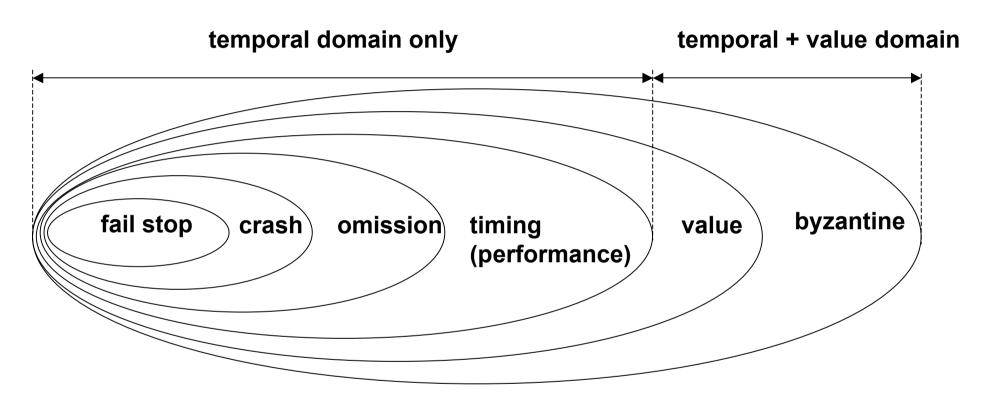
Crash Failures:

Component does not deliver any data.

Fail Stop:

Failed component stops to produce results. Components are able to diagnose the Crash Failure correctly.





masking resend, time-out, duplicate msg. recognition and removal, mapping check sum, replication, majority voting.

The Network or the Node?

Fault-assumptions in Distributed Systems

Fault Class	affects:	description
fail stop	process	A process crashes and remains inactive. All all participants safely detect this state.
crash	process	A process crashes and remains inactive. Other processes amy not detect this state.
omission	channel	A message in the output message buffer of one process never reaches the input message buffer of the other process.
- send om.	channel	A process completes the send but the respective message is never written in its send output buffer.
- receive om.	channel	A message is written in the input message buffer of a process but never processed.
byzantine	process	An arbitrary behaviour of a process.

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Reliable 1-to-1 Communication:

Validity: every message which is sent (queued in the out-buffer of a

correct process) will eventually be received (queued in the

in-buffer of an correct process)

Integrity: the message received is identical with the message sent and

no message is delivered more than once.

Validity and integrity are properties of a channel!

UDP provides a Channels with Omission Faults and doesn't guarantee any order. TCP provides a Reliable FiFo-Ordered Point-to-Point Connection (Channel)

Mechanisms	Effect
sequence numbers assigned to packets	FiFo between sender and receiver. Allows to detect duplicates.
acknowledge of packets	Allows to detect missing packets on the sender side and initiates retransmission
Checksum for data segments	Allows detection of value failures.
Flow Control	Receiver sends expected "window size" characterizing the amount of data for future transmissions together with ack.

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Failure Detectors and Consistency of Distributed Failure Detection

Intuitive Consistency Criterion:

When a process fails, all correct processes are able to detect the failure and achieve consensus about the faulty process.

Formalisation by Chandra and Tueg (1996):

Strong Acuracy (SA): No correct process ever is considered to be faulty. (safety criterion)

Strong Completeness (SC): A faulty process eventually will be detected by every correct process (liveness criterion).

Assumptions:

- 1. Transmission delays can be bounded.
- 2. Processes can generate and send a "heartbeat" message periodically in a bounded time interval.
- 3. We assume a crash failure model, i.e. the network is fault-free.



Heartbeat-mechanism is a perfect failure detector

Assumptions:

- 1. Transmission delays can be bounded.
- 2. Processes can generate and send a "heartbeat" message periodically in a bounded time interval.
- 3. We assume an omission failure model, however the omissions may be bounded.

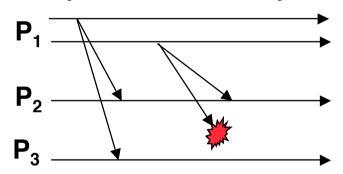


Apply mechanisms to mask omissions.

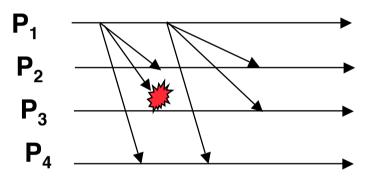
FT communication - Handling message failures

Static Redundancy: Masking Failures

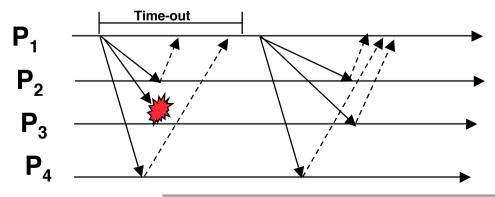
component redundancy



time redundancy



Dynamic Redundancy: Detection + Recovery



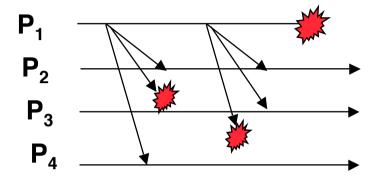


FT Communication - Handling sender failures

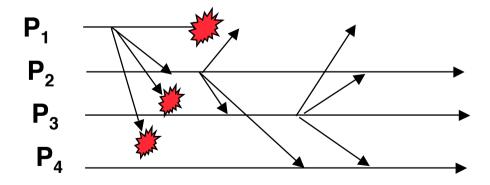
Unreliable Multicast

P₁ P₂ P₃ P₄

Best effort Multicast



Reliable Multicast



Imperfect failure detectors

Assumptions:

Temporal assumptions:

- 1. the latency of messages cannot be bounded,
- 2. processes cannot always produce a heartbeat in a bounded interval.

Assmptions about the number of faults:

3. The number of omissions cannot be bounded.



No deterministic decision can be derived whether a process has failed or not.

Consensus in Distributed Systems

Goal: A group of processes agree on a common value.

Every process proposes a value once.

Every process decide a value once.

Proposed and decided values are 0 or 1 (simplification).

The following conditions must be achieved:

Consistency: All processes eventually agree on the same value and

(Agreement) the decision is final.

Non Triviality: The decided value has been proposed by some process.

(Validity)

Termination: Every correct process decides on the common value within

a finite time interval.



FLP Impossibility Result

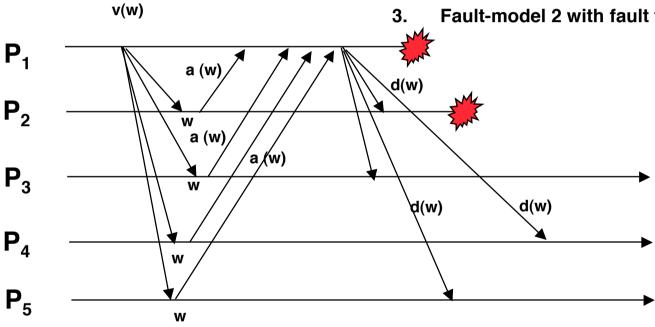
Michael J. Fischer, Nancy A. Lynch, and Michael S. Paterson. Impossibility of distributed consensus with one faulty process. Journal of the ACM, 32(2):374(382, April 1985.



Fault-Tolerant Consensus

Assumptions:

- The latency of messages is bounded. 1.
- 2. Failure detection is reliable.
- Fault-model 2 with fault treatment.

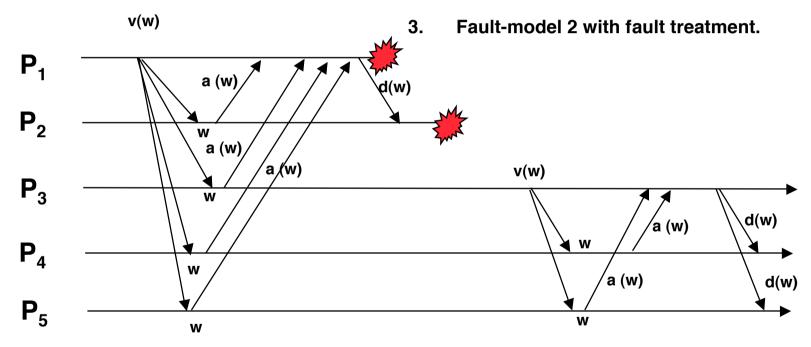


v(w): suggest(w) a(w): accepted (w) d(w): decided (w)

Fault-Tolerant Consensus

Assumptions:

- 1. The latency of messages is bounded.
- 2. Failure detection is reliable.



v(w): suggest(w)

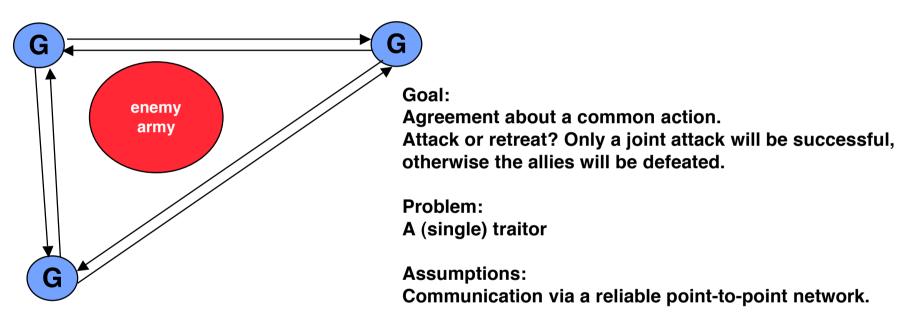
a(w): accepted (w)

d(w): decided (w)

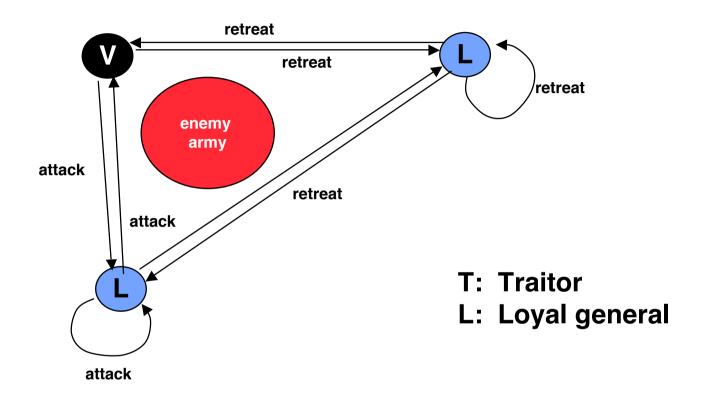


L. Lamport, R. Shostak, M. Pease: "The byzantine generals' problem", ACM TC on Progr. Languages and systems, 4(3), 1982

The Story:



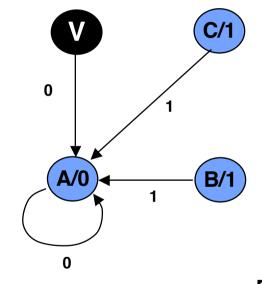
Under which conditions and by which protocol is it possible to derive a correct majority vote?



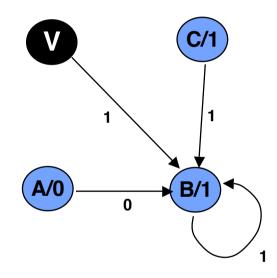
Even multiple rounds will not help to achieve agreement because a loyal general never knows who is the traitor.

Agreement on a value in two rounds

messages, that reach A



messages, that reach B



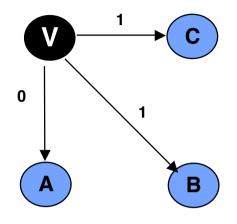
Distribution of values

1. round

During the first round no unambiguous decision is possible because A and B don't agree.

1. round

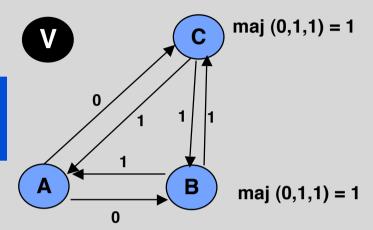
distribution of values from some participant



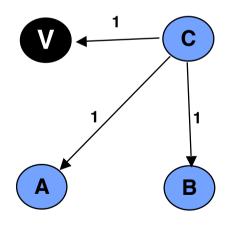
1. case sender is the traitor

2. round

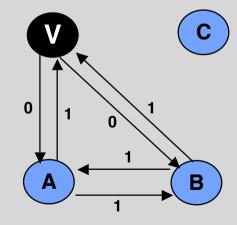
agreement on a value proposed by some participant.



maj(0,1,1) = 1



2. case traitor disseminates a faulty value.



maj(0,1,1) = 1

maj(0,1,1) = 1

- Participants are processes.
- Evenry process locally desides by majority voting on the value that is decided by evera correct process.
- The value decided by the majority of processes is the corect value.
- To detect f byzantine faults,

(3f + 1) processes are needed.